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(Z)-N-[(2*R*,3*R*)-2-(*tert*-Butoxycarbonylamino)-3-(*tert*-butyldiphenylsiloxy)butylidene]benzylamine *N*-Oxide

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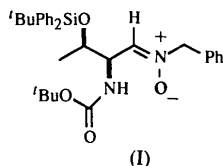
Abstract

The title compound, $C_{32}H_{42}N_2O_4Si$, is a key intermediate in the stereoselective synthesis of α,β -diaminoaldehydes, α,β -diaminoacids and chiral 1,2-diamines. The X-ray structure determination shows that the nitronium $[C-CH=N^+(O^-)-C]$ system is planar with torsion angles of 175 ($H1-C1-N1-O1$) and 175.0° ($C2-C1-N1-C5$).

Comment

As part of a project directed toward the synthesis of chiral α,β -diaminoaldehydes, α,β -diaminoacids and 1,2-diamines, we described a stereodivergent procedure in which chiral nitrones derived from natural α -amino acids were used as suitable starting materials. The arrangement of the protecting groups in the nitronium is crucial for the selectivity of the process (Dondoni, Merchan, Merino, Tejero & Bertolasi, 1994).

Study the interaction of the nitronium functionality with its vicinal groups should aid the elucidation of the reactivity of the title nitronium, (I), derived from L-threonine. The present structure analysis shows that



a plausible hydrogen bond $O1 \cdots H(N2)$ is, in fact, impossible as a result of the bulkiness of the *tert*-butyldiphenylsilyl group. The molecular geometry and numbering scheme are shown in Fig. 1. The *Z* configuration of the nitronium is confirmed, as well as the planarity of

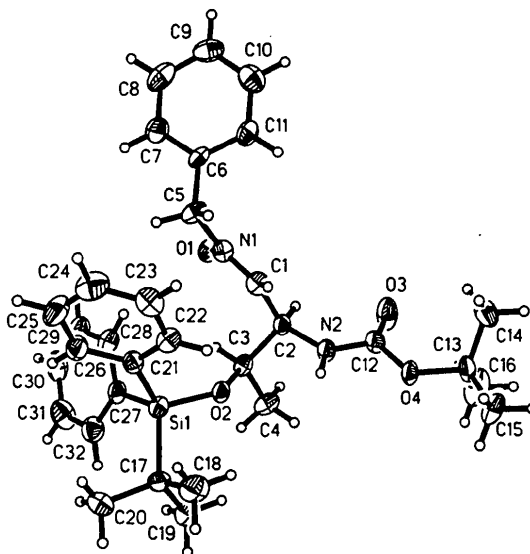


Fig. 1. Molecular configuration and atom-numbering scheme of the title compound. Displacement ellipsoids are plotted at the 30% probability level.

the important nitronium atoms C1, H1, N1 and O1. Atoms C2 and C5 are also coplanar with the nitronium moiety.

Experimental

The synthesis was carried out by reaction of the corresponding aldehyde with *N*-benzylhydroxylamine by the method described previously (Dondoni, Franco, Junquera, Merchan, Merino & Tejero, 1994). The compound was purified by column chromatography and crystals suitable for X-ray experiments were obtained by slow evaporation of the solvents [m.p. = 400 K; $[\alpha]_D = -24.3^\circ$ (c 1.2 g 100 ml⁻¹, chloroform)].

Crystal data

$C_{32}H_{42}N_2O_4Si$
 $M_r = 546.77$
 Orthorhombic
 $P2_12_12_1$
 $a = 10.002$ (2) Å
 $b = 14.274$ (3) Å
 $c = 21.976$ (4) Å
 $V = 3137.5$ (11) Å³
 $Z = 4$
 $D_x = 1.158$ Mg m⁻³

Mo $K\alpha$ radiation
 $\lambda = 0.71073$ Å
 Cell parameters from 39 reflections
 $\theta = 9.45$ – 21.85°
 $\mu = 0.111$ mm⁻¹
 $T = 293$ (2) K
 Transparent block
 $0.5 \times 0.3 \times 0.2$ mm
 Colourless

Data collection

Siemens P4 diffractometer
 Profile data from $2\theta/\omega$ scans
 Absorption correction: semi-empirical (ellipsoidal) refined from ψ scan (North, Phillips & Mathews, 1968)
 $T_{min} = 0.652$, $T_{max} = 0.841$
 3015 measured reflections
 2827 independent reflections

1648 observed reflections
 $[I > 2\sigma(I)]$
 $R_{int} = 0.0633$
 $\theta_{max} = 22.50^\circ$
 $h = -1 \rightarrow 10$
 $k = -1 \rightarrow 15$
 $l = -1 \rightarrow 23$
 3 standard reflections monitored every 97 reflections
 intensity decay: 7.26%

Refinement

Refinement on F^2
 $R[F^2 > 2\sigma(F^2)] = 0.0568$
 $wR(F^2) = 0.1148$
 $S = 1.132$
 2824 reflections
 398 parameters
 H atoms refined as riding
 model (except for H1)
 $w = 1/[\sigma^2(F_o^2) + (0.0580P)^2 + 0.7204P]$
 where $P = (F_o^2 + 2F_c^2)/3$
 $(\Delta/\sigma)_{\max} = 0.004$

$\Delta\rho_{\max} = 0.211 \text{ e } \text{Å}^{-3}$
 $\Delta\rho_{\min} = -0.176 \text{ e } \text{Å}^{-3}$
 Extinction correction:
SHELXL93 (Sheldrick,
 1993)
 Extinction coefficient:
 0.0047 (12)
 Atomic scattering factors
 from *International Tables*
 for *Crystallography* (1992,
 Vol. C, Tables 4.2.6.8 and
 6.1.1.4)

Data collection: *XSCANS* (Siemens, 1992). Cell refinement:
XSCANS. Data reduction: *XSCANS*. Program(s) used to solve
 structure: *SHELXS86* (Sheldrick, 1990). Program(s) used to
 refine structure: *SHELXL93* (Sheldrick, 1993). Molecular
 graphics: *SHELXL93*. Software used to prepare material for
 publication: *SHELXL93*.

Lists of structure factors, anisotropic displacement parameters, H-
 atom coordinates and complete geometry have been deposited with
 the IUCr (Reference: NA1167). Copies may be obtained through The
 Managing Editor, International Union of Crystallography, 5 Abbey
 Square, Chester CH1 2HU, England.

Table 1. Fractional atomic coordinates and equivalent
 isotropic displacement parameters (Å^2)

$$U_{\text{eq}} = (1/3)\sum_i\sum_j U_{ij}a_i^*a_j^*a_i \cdot a_j$$

	x	y	z	U_{eq}
Si1	0.1246 (2)	0.78695 (15)	0.20606 (11)	0.0546 (7)
O1	-0.0369 (6)	0.7720 (4)	0.0152 (2)	0.065 (2)
O2	0.1262 (5)	0.6910 (3)	0.1658 (2)	0.0525 (14)
O3	0.1054 (7)	0.4455 (4)	0.0132 (3)	0.100 (3)
O4	0.2803 (6)	0.4099 (3)	0.0725 (2)	0.063 (2)
N1	0.0914 (7)	0.7677 (5)	0.0154 (3)	0.055 (2)
N2	0.1858 (7)	0.5468 (4)	0.0802 (3)	0.059 (2)
C1	0.1579 (10)	0.6998 (7)	0.0374 (4)	0.057 (2)
C2	0.0907 (8)	0.6208 (5)	0.0685 (4)	0.049 (2)
C3	0.0258 (8)	0.6509 (5)	0.1274 (4)	0.052 (2)
C4	-0.0431 (11)	0.5714 (7)	0.1594 (5)	0.075 (3)
C5	0.1614 (9)	0.8486 (6)	-0.0107 (4)	0.067 (3)
C12	0.1836 (9)	0.4668 (6)	0.0505 (4)	0.059 (3)
C13	0.3025 (10)	0.3178 (6)	0.0456 (4)	0.065 (3)
C14	0.3316 (21)	0.3272 (12)	-0.0206 (5)	0.140 (6)
C15	0.4256 (9)	0.2841 (6)	0.0796 (5)	0.083 (3)
C16	0.1822 (12)	0.2566 (8)	0.0570 (9)	0.122 (5)
C17	0.1880 (9)	0.7518 (6)	0.2820 (4)	0.060 (2)
C18	0.3295 (10)	0.7140 (9)	0.2736 (5)	0.094 (3)
C19	0.1073 (14)	0.6734 (7)	0.3090 (5)	0.092 (3)
C20	0.1950 (13)	0.8346 (8)	0.3262 (4)	0.093 (3)
C6	0.1243 (8)	0.8702 (6)	-0.0730 (4)	0.052 (2)
C7	0.0612 (9)	0.9496 (7)	-0.0878 (6)	0.074 (3)
C8	0.0371 (11)	0.9726 (8)	-0.1475 (7)	0.090 (3)
C9	0.0711 (11)	0.9128 (10)	-0.1930 (6)	0.087 (3)
C10	0.1299 (11)	0.8309 (9)	-0.1781 (5)	0.086 (3)
C11	0.1576 (9)	0.8087 (6)	-0.1174 (5)	0.068 (3)
C21	0.2363 (9)	0.8712 (6)	0.1683 (4)	0.056 (2)
C22	0.3434 (9)	0.8423 (7)	0.1335 (4)	0.063 (2)
C23	0.4251 (10)	0.9048 (9)	0.1038 (5)	0.078 (3)
C24	0.4053 (12)	0.9988 (9)	0.1094 (5)	0.089 (3)
C25	0.3016 (13)	1.0286 (8)	0.1455 (5)	0.096 (4)
C26	0.2204 (11)	0.9667 (6)	0.1746 (4)	0.074 (3)
C27	-0.0437 (8)	0.8425 (6)	0.2073 (5)	0.058 (2)
C28	-0.0941 (9)	0.8828 (6)	0.1557 (5)	0.065 (3)
C29	-0.2168 (11)	0.9262 (6)	0.1530 (6)	0.079 (3)
C30	-0.2891 (11)	0.9334 (7)	0.2036 (7)	0.090 (3)
C31	-0.2455 (12)	0.8969 (8)	0.2558 (7)	0.100 (4)
C32	-0.1233 (11)	0.8504 (7)	0.2581 (5)	0.078 (3)

Table 2. Selected geometric parameters (Å , $^\circ$)

O1—N1	1.285 (8)	C1—C2	1.480 (11)
O2—C3	1.431 (8)	C1—H1	0.86 (6)
N1—C1	1.271 (10)	C2—C3	1.510 (10)
N1—C5	1.467 (9)	C3—C4	1.503 (10)
C1—N1—O1	124.1 (8)	N1—C1—H1	125 (4)
C1—N1—C5	120.0 (7)	C2—C1—H1	113 (4)
O1—N1—C5	115.9 (7)	N2—C2—C1	109.9 (7)
N1—C1—C2	121.3 (8)	C1—C2—C3	112.0 (7)
C2—C1—N1—C5	175.0 (7)	H1—C1—N1—O1	-175 (5)

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Two Products of Ring Opening Reactions of an Arylthionitrooxirane

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Abstract

Crystal structure determination of the products, *S*-(4-
 methylphenyl) ($\alpha R, 4R$)- α -bromo-2,2-dimethyl-1,3-
 dioxolane-4-thioacetate, C₁₄H₁₇BrO₃S, (2), and *S*-(4-
 methylphenyl) ($\alpha R, 4R$)- α -(benzyloxycarbonylamino)-
 2,2-dimethyl-1,3-dioxolane-4-thioacetate, C₂₂H₂₅NO₅S,
 (3), of the two reactions, including absolute-structure
 assignment, shows that they proceed stereospecifically
 with inversion of configuration. Common groups of the
 two structures have essentially the same bond lengths
 and angles, but different conformations, arising from
 weak hydrogen bonding and van der Waals interactions.